Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/016,601	LUO ET AL.
		Examiner	Art Unit
		Dennis Rosario	2621

SEARCHED

Class	Subclass	Date	Examiner
382	205	06/06/05	DR
	(254)	(4/9/06) 09/09/05	(DR) DR
	(228)	09/09/05	DR
		(4/3/06)	(DR)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference			
PG pubs		4/6/06	DR
site printout			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Search	06/08/05	DR
	06/09/05	DR
(updated, all dB)	06/10/05 (09/09/05)	DR (DR)
	06/06/05	DR
	5/31/05	DR
IEEE Search	5/31/05	DR
382/103, 180,190, 203, 206, 228 - text	09/09/05	DR
Inventor / East and IEEE	09/09/05	DR
(IEEE update (- belief or probability or likihood and map -)	(09/09/05)	(DR)
(East - all dB)	(4/6/06)	(DR)
(IEEE - bayesian near network and sharp# or smooth# or enhac# -)	(4/3/06)	(DR)
(-belief near map and size or area -)	(3/31/06)	(DR)
Interference printout	4/6/06	DR